

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/052,847 | | Applicant(s)/Patent Under Reexamination YEUNG ET AL. | |
| | Examiner Asad M. Nawaz | | Art Unit 2155 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-2003/0020530 | 01-2003 | Lee et al. | 327/379 |
| * | B | US-2004/0163020 | 08-2004 | Sidman, David | 714/100 |
| * | C | US-2002/0169667 | 11-2002 | Marotta et al. | 705/14 |
| * | D | US-2003/0110188 | 06-2003 | Howard et al. | 707/200 |
| * | E | US-6,519,612 | 02-2003 | Howard et al. | 707/200 |
| * | F | US-6,496,837 | 12-2002 | Howard et al. | 707/200 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.